



# 25-V N-Channel NexFET™ Power MOSFETs

Check for Samples: CSD16556Q5B

## **FEATURES**

- Extremely Low Resistance
- Ultralow Q<sub>q</sub> and Q<sub>qd</sub>
- Low Thermal Resistance
- · Avalanche Rated
- · Pb Free Terminal Plating
- RoHS Compliant
- Halogen Free
- SON 5-mm × 6-mm Plastic Package

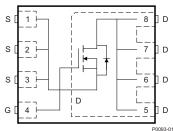
#### **APPLICATIONS**

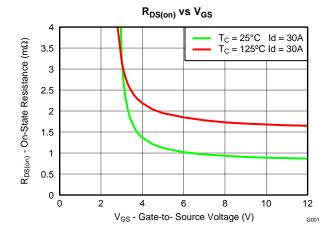
- Point-of-Load Synchronous Buck in Networking, Telecom, and Computing Systems
- Optimized for Synchronous FET Applications

#### DESCRIPTION

The NexFET™ power MOSFET has been designed to minimize losses in synchronous rectification and other power conversion applications.







#### **PRODUCT SUMMARY**

$T_A = 25^{\circ}$	C unless otherwise stated	TYPICAL V	UNIT	
$V_{DS}$	Drain to Source Voltage 25			V
$Q_g$	Gate Charge Total (4.5V) 36			
$Q_{gd}$	Gate Charge Gate to Drain	12		nC
D	Drain to Source On Resistance	$V_{GS} = 4.5V$	1.2	mΩ
R <sub>DS(on)</sub>	Drain to Source On Resistance	$V_{GS} = 10V$	0.9	mΩ
V <sub>GS(th)</sub>	Threshold Voltage	1.4		V

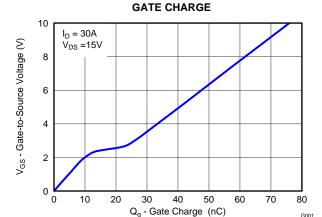
#### ORDERING INFORMATION

Device	Package	Media	Qty	Ship
CSD16556Q5B	SON 5-mm × 6-mm Plastic Package	13-Inch Reel	2500	Tape and Reel

#### **ABSOLUTE MAXIMUM RATINGS**

T <sub>A</sub> = 2	5°C unless otherwise stated	VALUE	UNIT	
$V_{DS}$	Drain to Source Voltage	25	٧	
$V_{GS}$	Gate to Source Voltage	±20	٧	
	Continuous Drain Current (Package limited), $T_C = 25^{\circ}C$	100	А	
I <sub>D</sub>	Continuous Drain Current (Silicon limited), $T_C = 25^{\circ}C$	mited), 263		
	Continuous Drain Current <sup>(1)</sup>	40	Α	
$I_{DM}$	Pulsed Drain Current, T <sub>A</sub> = 25°C <sup>(1)(2)</sup>	249	Α	
P <sub>D</sub>	Power Dissipation <sup>(1)</sup>	3.2	W	
T <sub>J</sub> , T <sub>STG</sub>	Operating Junction and Storage Temperature Range	-55 to 150	°C	
E <sub>AS</sub>	Avalanche Energy, single pulse $I_D = 103A, L = 0.1mH, R_G = 25\Omega$	530	mJ	

- (1) Typical  $R_{\theta JA}=40^{\circ} C/W$  on 1-inch² (6.45-cm²), 2-oz. (0.071-mm thick) Cu pad on a 0.06-inch (1.52-mm) thick FR4 PCB.
- (2) Pulse duration ≤300µs, duty cycle ≤2%



AAA

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NexFET is a trademark of Texas Instruments.





These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

### **ELECTRICAL CHARACTERISTICS**

(T<sub>A</sub> = 25°C unless otherwise stated)

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Static Cl	naracteristics					
BV <sub>DSS</sub>	Drain to Source Voltage	$V_{GS} = 0V, I_{DS} = 250\mu A$	25			V
I <sub>DSS</sub>	Drain to Source Leakage Current	V <sub>GS</sub> = 0V, V <sub>DS</sub> = 24V			1	μΑ
I <sub>GSS</sub>	Gate to Source Leakage Current	$V_{DS} = 0V, V_{GS} = 20V$			100	nA
$V_{GS(th)}$	Gate to Source Threshold Voltage	$V_{DS} = V_{GS}, I_{DS} = 250 \mu A$	1.2	1.4	1.7	V
_	Dunin to Course On Bonintones	$V_{GS} = 4.5V, I_{DS} = 30A$		1.2	1.5	mΩ
R <sub>DS(on)</sub>	Drain to Source On Resistance	V <sub>GS</sub> = 10V, I <sub>DS</sub> = 30A		0.9	1.07	mΩ
9 <sub>fs</sub>	Transconductance	V <sub>DS</sub> = 15V, I <sub>DS</sub> = 30A		191		S
Dynamic	: Characteristics					
C <sub>iss</sub>	Input Capacitance			4750	6180	pF
C <sub>oss</sub>	Output Capacitance	$V_{GS} = 0V, V_{DS} = 15V,$ f = 1MHz		2270	2950	pF
C <sub>rss</sub>	Reverse Transfer Capacitance	1 - 11/11/2		220	280	pF
$R_G$	Series Gate Resistance			0.7	1.4	Ω
Qg	Gate Charge Total (4.5V)			36	47	nC
Q <sub>gd</sub>	Gate Charge Gate to Drain	V 45V L 20A		12		nC
Q <sub>gs</sub>	Gate Charge Gate to Source	$V_{DS} = 15V, I_{DS} = 30A$		11		nC
Q <sub>g(th)</sub>	Gate Charge at Vth			7.0		nC
Q <sub>oss</sub>	Output Charge	V <sub>DS</sub> = 15V, V <sub>GS</sub> = 0V		45		nC
t <sub>d(on)</sub>	Turn On Delay Time			17		ns
t <sub>r</sub>	Rise Time	V <sub>DS</sub> = 15V, V <sub>GS</sub> = 4.5V,		34		ns
t <sub>d(off)</sub>	Turn Off Delay Time	$I_{DS} = 30A, R_G = 2\Omega$		4750 2270 220 0.7 36 12 11 7.0 45		ns
t <sub>f</sub>	Fall Time			13		ns
Diode Cl	haracteristics					
$V_{SD}$	Diode Forward Voltage	I <sub>SD</sub> = 30A, V <sub>GS</sub> = 0V		0.8	1	V
Q <sub>rr</sub>	Reverse Recovery Charge	V 45V I 20A di/dt 2024/:-		84		nC
t <sub>rr</sub>	Reverse Recovery Time	$V_{DD}$ = 15V, $I_F$ = 30A, di/dt = 300A/ $\mu$ s		41		ns

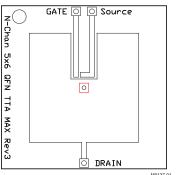
### THERMAL CHARACTERISTICS

(T<sub>A</sub> = 25°C unless otherwise stated)

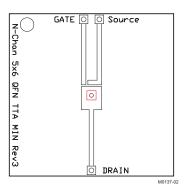
	PARAMETER	MIN	TYP	MAX	UNIT
$R_{\theta JC}$	Thermal Resistance Junction to Case <sup>(1)</sup>			1.1	°C/W
$R_{\theta JA}$	Thermal Resistance Junction to Ambient <sup>(1)(2)</sup>			50	°C/W

 $R_{\theta JC}$  is determined with the device mounted on a 1-inch<sup>2</sup> (6.45-cm<sup>2</sup>), 2-oz. (0.071-mm thick) Cu pad on a 1.5-inch × 1.5-inch (3.81-cm × 3.81-cm), 0.06-inch (1.52-mm) thick FR4 PCB.  $R_{\theta JC}$  is specified by design, whereas  $R_{\theta JA}$  is determined by the user's board design. Device mounted on FR4 material with 1-inch<sup>2</sup> (6.45-cm<sup>2</sup>), 2-oz. (0.071-mm thick) Cu.





Max  $R_{\theta JA} = 50^{\circ} C/W$  when mounted on 1 inch² (6.45 cm²) of 2-oz. (0.071-mm thick) Cu.



Max  $R_{\theta JA} = 125^{\circ} C/W$  when mounted on a minimum pad area of 2-oz. (0.071-mm thick) Cu.

# TYPICAL MOSFET CHARACTERISTICS

(T<sub>A</sub> = 25°C unless otherwise stated)

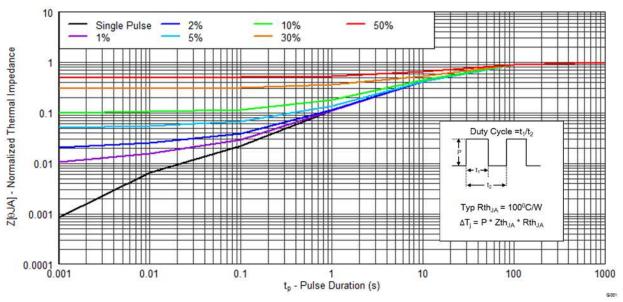


Figure 1. Transient Thermal Impedance

# TYPICAL MOSFET CHARACTERISTICS (continued)

(T<sub>A</sub> = 25°C unless otherwise stated)

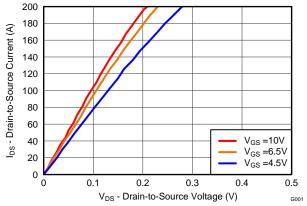


Figure 2. Saturation Characteristics

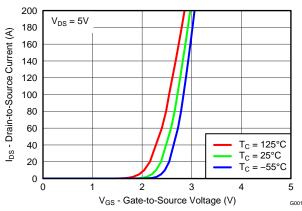


Figure 3. Transfer Characteristics

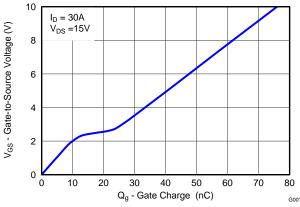


Figure 4. Gate Charge

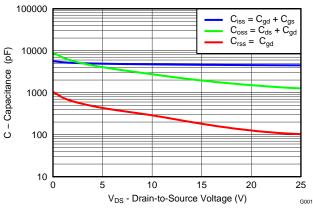


Figure 5. Capacitance

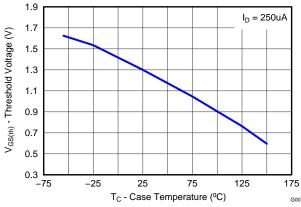


Figure 6. Threshold Voltage vs. Temperature

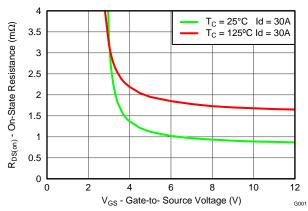


Figure 7. On-State Resistance vs. Gate-to-Source Voltage



## TYPICAL MOSFET CHARACTERISTICS (continued)

## (T<sub>A</sub> = 25°C unless otherwise stated)

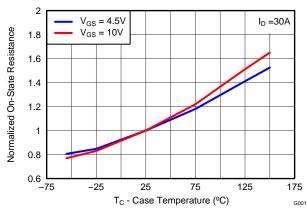


Figure 8. Normalized On-State Resistance vs. Temperature

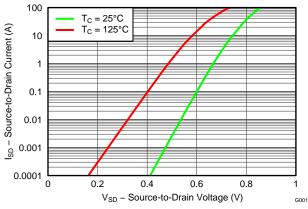


Figure 9. Typical Diode Forward Voltage

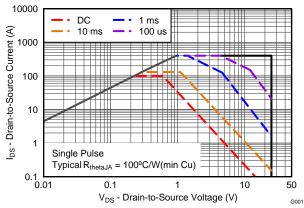


Figure 10. Safety Operating Area  $T_c = 25^{\circ}$  C

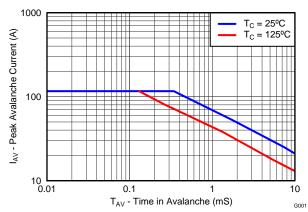


Figure 11. Single Pulse Unclamped Inductive Switching

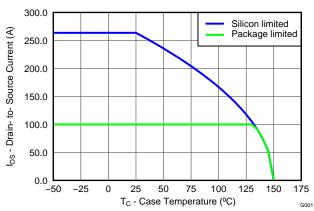
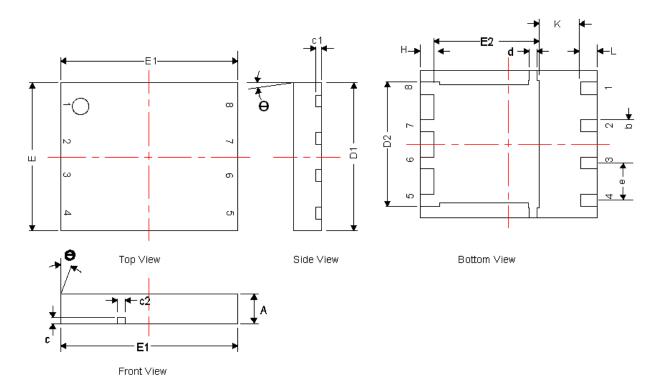


Figure 12. Maximum Drain Current vs. Temperature



## **MECHANICAL DATA**

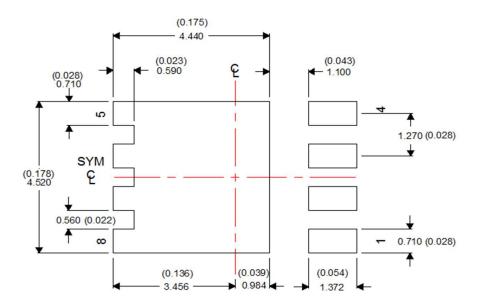
# **Q5B Package Dimensions**



DIM	MILLIMETERS							
DIM	MIN	NOM	MAX					
Α	0.95	1.00	1.05					
b	0.36	0.41	0.46					
С	0.15	0.20	0.25					
c1	0.15	0.20	0.25					
c2	0.20	0.25	0.30					
D1	4.90	5.00	5.10					
D2	4.12	4.22	4.32					
d	0.20	0.25	0.30					
E	4.90	5.00	5.10					
E1	5.90	6.00	6.10					
E2	3.48	3.58	3.68					
е		1.27 TYP						
L	0.46	0.56	0.66					
θ	0°	-	-					
K		1.40 TYP						

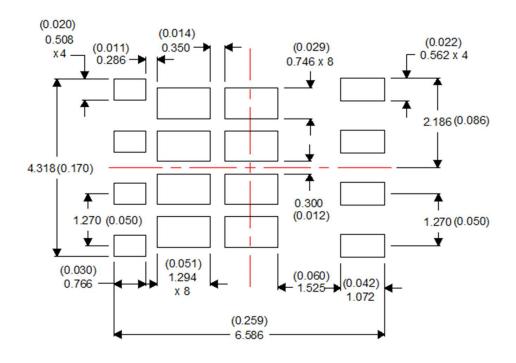


### **Recommended PCB Pattern**



For recommended circuit layout for PCB designs, see application note SLPA005 – Reducing Ringing Through PCB Layout Techniques.

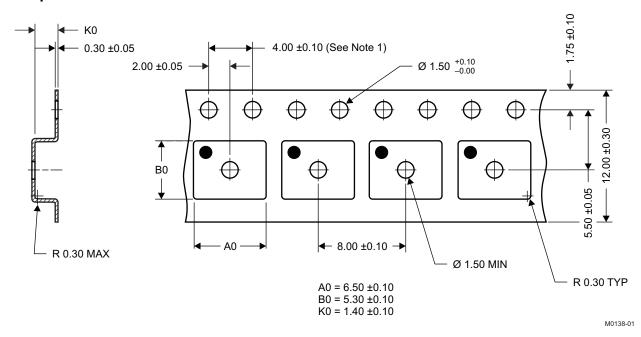
## **Recommended Stencil Pattern**



Product Folder Links: CSD16556Q5B



## **Q5B Tape and Reel Information**



#### Notes:

- 1. 10-sprocket hole-pitch cumulative tolerance ±0.2
- 2. Camber not to exceed 1mm in 100mm, noncumulative over 250mm
- 3. Material: black static-dissipative polystyrene
- 4. All dimensions are in mm (unless otherwise specified)
- 5. A0 and B0 measured on a plane 0.3mm above the bottom of the pocket

## **REVISION HISTORY**

Changes from Original (November 2012) to Revision A	Page
Changes from Original (November 2012) to Revision A  Changed the device From Product Preview To: Production  Changes from Revision A (December 2012) to Revision B  Changed g <sub>fs</sub> , Transconductance TYP value From: 2 S To: 191 S	1
Changes from Revision A (December 2012) to Revision B	Page
Changed g <sub>fs</sub> , Transconductance TYP value From: 2 S To: 191 S	2





8-Jan-2013

#### **PACKAGING INFORMATION**

Orderable Device	Status	Package Type	_	Pins	Package Qty	Eco Plan	Lead/Ball Finish	MSL Peak Temp	Samples
	(1)		Drawing			(2)		(3)	(Requires Login)
CSD16556Q5B	ACTIVE	VSON	DNK	8	2500	Pb-Free (RoHS Exempt)	CU SN	Level-1-260C-UNLIM	

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

**TBD:** The Pb-Free/Green conversion plan has not been defined.

**Pb-Free** (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes. **Pb-Free** (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

(3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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# PACKAGE MATERIALS INFORMATION

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## TAPE AND REEL INFORMATION





		Dimension designed to accommodate the component width
E	30	Dimension designed to accommodate the component length
K	(0	Dimension designed to accommodate the component thickness
	N	Overall width of the carrier tape
F	21	Pitch between successive cavity centers

## QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



### \*All dimensions are nominal

Device	Package Type	Package Drawing			Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
CSD16556Q5B	VSON	DNK	8	2500	330.0	12.8	6.5	5.3	1.4	8.0	12.0	Q1

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#### \*All dimensions are nominal

ĺ	Device	Device Package Type		Pins	SPQ	Length (mm)	Width (mm)	Height (mm)	
	CSD16556Q5B	VSON	DNK	8	2500	335.0	335.0	32.0	

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#### Products Applications

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